

Notice of References Cited	Application/Control No. 10/730,382		Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner Martin J. Angebrandt		Art Unit 1756	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,904,569	02-1990	Fukuda et al.	430/311
*	B	US-7,081,328	07-2006	Todori et al.	430/270.11
*	C	US-6,339,582	01-2002	Ichihara et al.	369/275.2
*	D	US-6,661,745	12-2003	Tominaga et al.	369/13.33
*	E	US-6,721,040	04-2004	Saito et al.	355/69
*	F	US-2003/0081300	05-2003	Spoonhower et al.	359/200
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	11-250501	09-1999	Japan	***	***
	O	06-044609	02-1994	Japan	Nakamura	***
	P	2001-057329	02-2001	Japan	Naito	***
	Q	580346	01-1994	EP	Iida et al.	***
	R	99/21934	05-1999	WIPO	Liz-Marzan et al.	***
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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